

# CAS325M12HM2

## 1.2kV, 3.6 mΩ All-Silicon Carbide High Performance, Half-Bridge Module C2M MOSFET and Z-Rec™ Diode

$V_{DS}$	1.2 kV
$E_{sw, Total @ 600V, 300A}$	9.3 mJ
$R_{DS(on)}$	3.6 mΩ

### Features

- Ultra Low Loss, Low (5 nH) Inductance
- Ultra-Fast Switching Operation
- Zero Reverse Recovery Current from Diode
- Zero Turn-off Tail Current from MOSFET
- Normally-off, Fail-safe Device Operation
- AlSiC Baseplate and Si3N4 AMB Substrate
- Ease of Paralleling
- High Temperature Packaging,  $T_{J(max)} = 175\text{ °C}$
- AS9100 / ISO9001 Certified Manufacturing

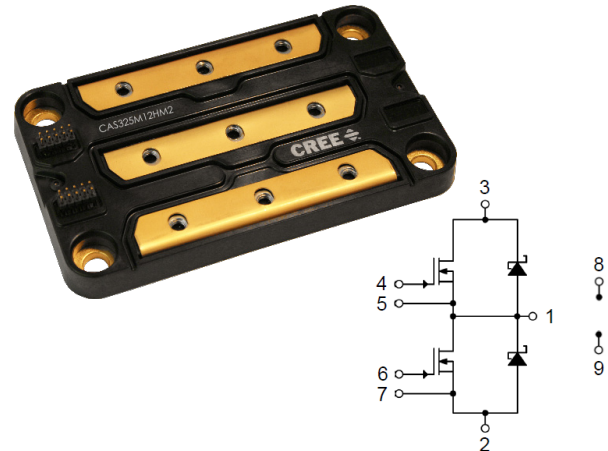
### System Benefits

- Enables Compact, Lightweight Systems
- High Efficiency Operation
- Reduced Thermal Requirements
- Reduced System Cost

### Applications

- High-Efficiency Converters / Inverters
- Motor & Traction Drives
- Smart-Grid / Grid-Tied Distributed Generation

Package 65mm x 110mm x 10mm



Part Number	Package	Marking
CAS325M12HM2	Half-Bridge Module	CAS325M12HM2

### Maximum Ratings ( $T_c = 25\text{ °C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Notes
$V_{DSmax}$	Drain - Source Voltage	1.2	kV		
$V_{GSmax}$	Gate - Source Voltage, Maximum values	-5/+25	V	$T_J = -55\text{ to }150\text{ °C}$	
		-5/+23		$T_J = -55\text{ to }175\text{ °C}$	
$V_{GSop}$	Gate - Source Voltage, Recommended Operation values	-5/+20	V	$T_J = -55\text{ to }150\text{ °C}$	
		-5/+18		$T_J = -55\text{ to }175\text{ °C}$	
$I_D$	Continuous Drain Current	444	A	$T_c = 25\text{ °C}, T_J = 175\text{ °C}$	Fig. 24
		256		$T_c = 125\text{ °C}, T_J = 175\text{ °C}$	
$T_{Jmax}$	Junction Temperature	175	°C		
$T_c, T_{STG}$	Case and Storage Temperature Range	-55 to +175	°C		
$V_{isol}$	Case Isolation Voltage	1.2	kV	AC, 50 Hz, 1 min	
$P_D$	Power Dissipation	3000	W	$T_c = 25\text{ °C}, T_J = 175\text{ °C}$	Fig. 23

**Electrical Characteristics ( $T_c = 25^\circ\text{C}$  unless otherwise specified)**

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain - Source Breakdown Voltage	1.2			kV		
$V_{GS(th)}$	Gate Threshold Voltage	2.0	2.6	4	V	$V_{DS} = V_{GS}, I_D = 105\text{ mA}$	
			2.0			$V_{DS} = V_{GS}, I_D = 105\text{ mA}, T_J = 175^\circ\text{C}$	
$I_{DSS}$	Zero Gate Voltage Drain Current		720	2000	$\mu\text{A}$	$V_{DS} = 1.2\text{ kV}, V_{GS} = -5\text{ V}$	
$I_{GSS}$	Gate-Source Leakage Current			3.5	nA	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$	
$R_{DS(on)}$	On State Resistance		3.6	4.3	m $\Omega$	$V_{GS} = 20\text{ V}, I_{DS} = 400\text{ A}$	Fig. 3
			7.6			$V_{GS} = 18\text{ V}, I_{DS} = 400\text{ A}, T_J = 175^\circ\text{C}$	
$C_{iss}$	Input Capacitance		19.5		nF	$V_{GS} = 0\text{ V}, V_{DS} = 1000\text{ V}, f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	Fig. 11, 12
$C_{oss}$	Output Capacitance		1.54				
$C_{rss}$	Reverse Transfer Capacitance		0.10				
$E_{on}$	Turn-On Switching Energy		5.6		mJ	$V_{DD} = 600\text{ V}, V_{GS} = -5\text{V}/+20\text{V}$ $I_D = 300\text{ A}, R_{G(ext)} = 2\Omega$ Note: IEC 60747-8-4 Definitions	Fig. 13, 14
$E_{off}$	Turn-Off Switching Energy		3.7				
$Q_{GS}$	Gate-Source Charge		322		nC	$V_{DS} = 800\text{ V}, V_{GS} = -5\text{V}/+20\text{V}, I_D = 350\text{ A}$ , Per IEC 60747-8-4	
$Q_{GD}$	Gate-Drain Charge		350				
$Q_G$	Total Gate Charge		1127				

**Free-Wheeling SiC Schottky Diode Characteristics**

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode Forward Voltage		1.7	2.0	V	$I_F = 350\text{ A}, V_{GS} = -5\text{ V}$	
			2.5	2.8		$I_F = 350\text{ A}, T_J = 175^\circ\text{C}, V_{GS} = -5\text{ V}$	
$Q_C$	Total Capacitive Charge		4.3		$\mu\text{C}$	Includes Schottky & Body diodes	

Note: The reverse recovery is purely capacitive

**Thermal Characteristics**

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$R_{thJCM}$	Thermal Resistance Junction-to-Case for MOSFET	0.085	0.100	0.115	$^\circ\text{C}/\text{W}$		Fig. 18,19
$R_{thJCD}$	Thermal Resistance Junction-to-Case for Diode	0.094	0.110	0.127			

**Additional Module Data**

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Condition
W	Weight		140		g	
M	Mounting Torque	0.9	1.1	1.3	Nm	Power Terminals, M4 Bolts
		3	4.5	5		Baseplate, M6 Bolts
$L_{CE}$	Loop Inductance		5		nH	

## Typical Performance

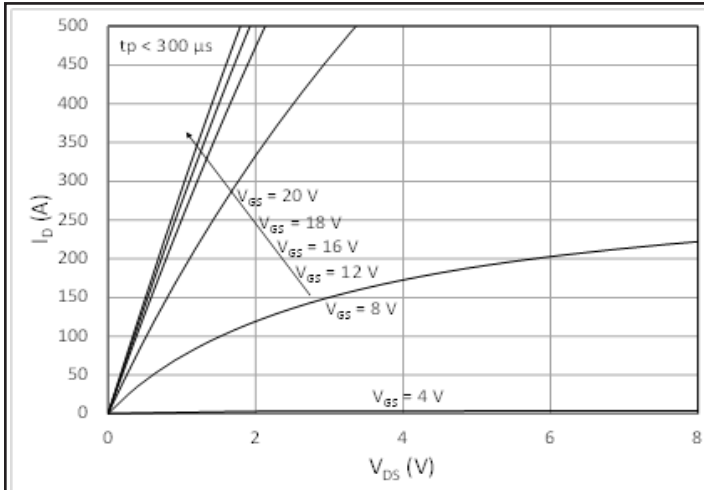


Figure 1. Typical Output Characteristics  $T_j = 25\text{ }^\circ\text{C}$

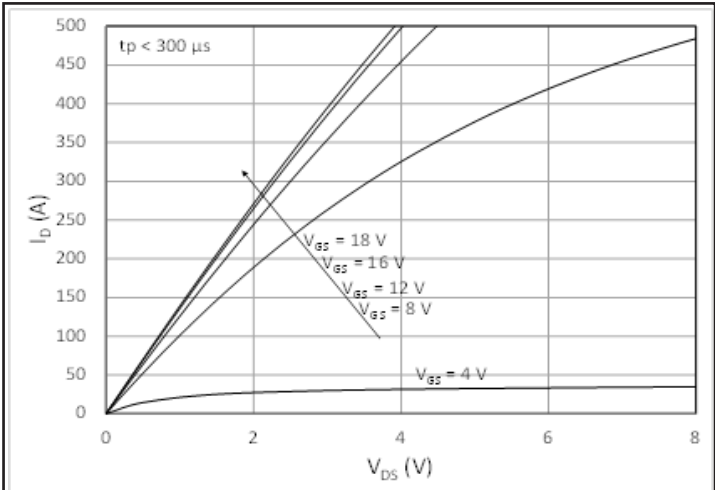


Figure 2. Typical Output Characteristics  $T_j = 125\text{ }^\circ\text{C}$

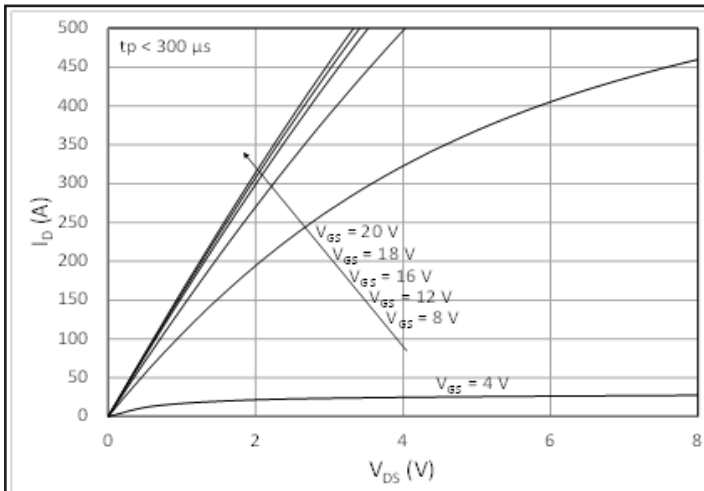


Figure 3. Typical Output Characteristics  $T_j = 150\text{ }^\circ\text{C}$

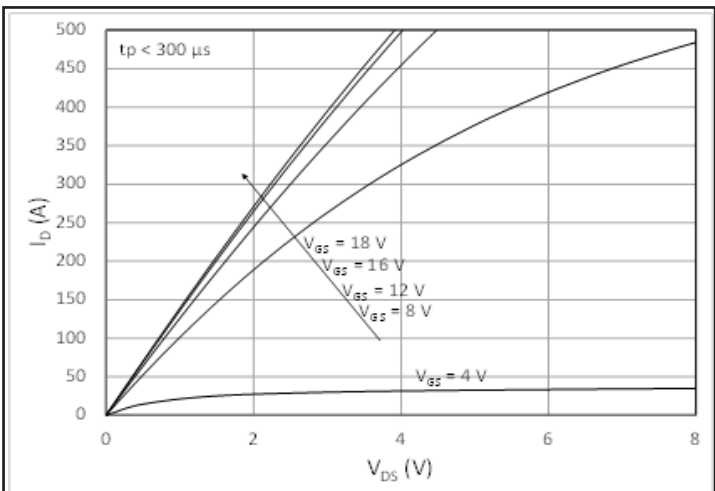


Figure 3. Typical Output Characteristics  $T_j = 175\text{ }^\circ\text{C}$

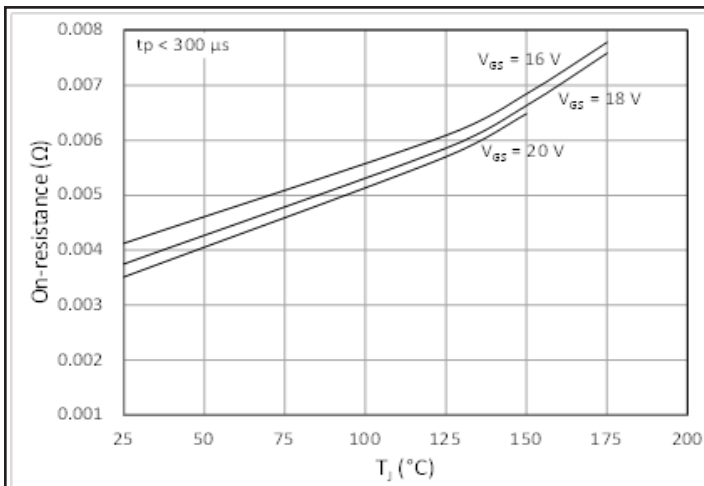


Figure 5. On-Resistance vs. Temperature for Various Gate-Source Voltage

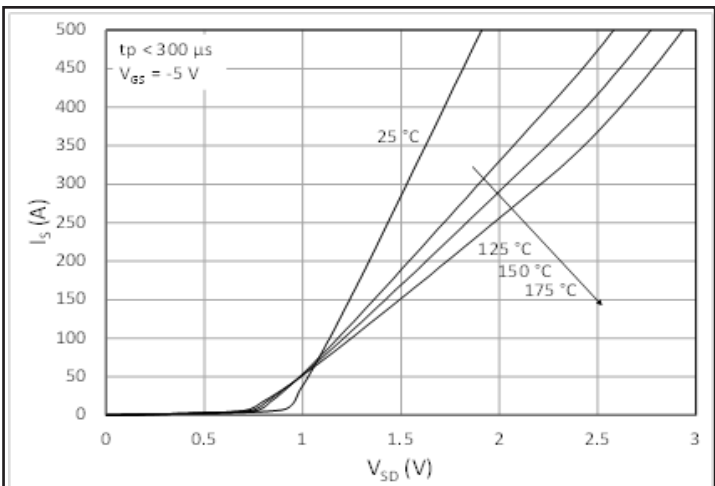


Figure 6. Antiparallel Diode Characteristic,  $V_{GS} = -5\text{ V}$

## Typical Performance

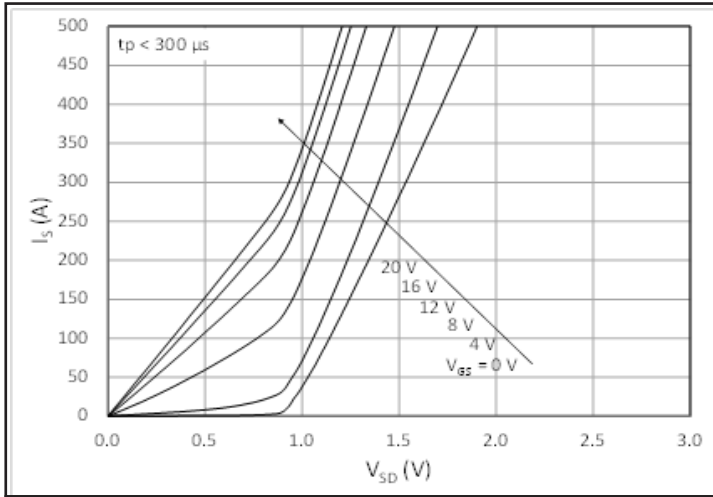


Figure 7. 3<sup>rd</sup> Quadrant Characteristic at 25 °C

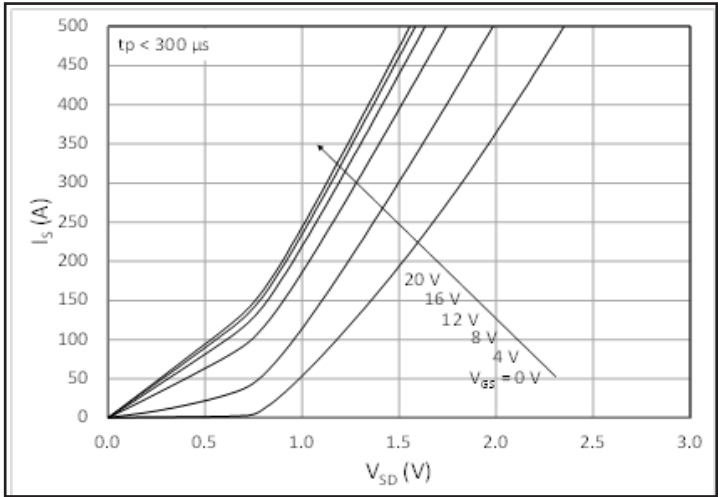


Figure 8. 3<sup>rd</sup> Quadrant Characteristic at 125 °C

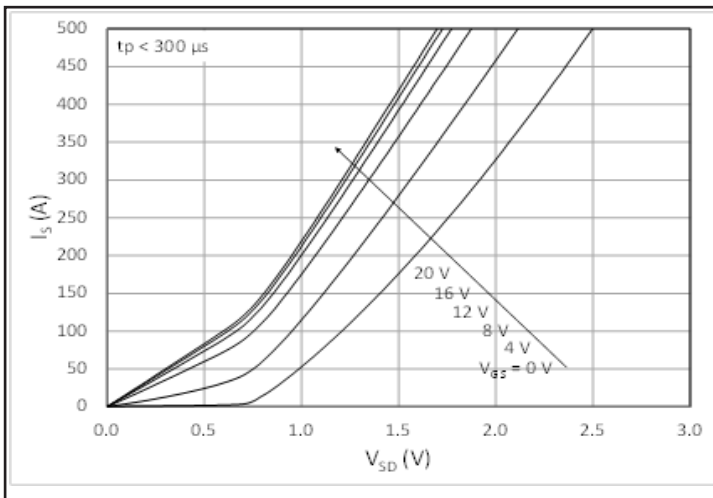


Figure 9. 3<sup>rd</sup> Quadrant Characteristic at 150 °C

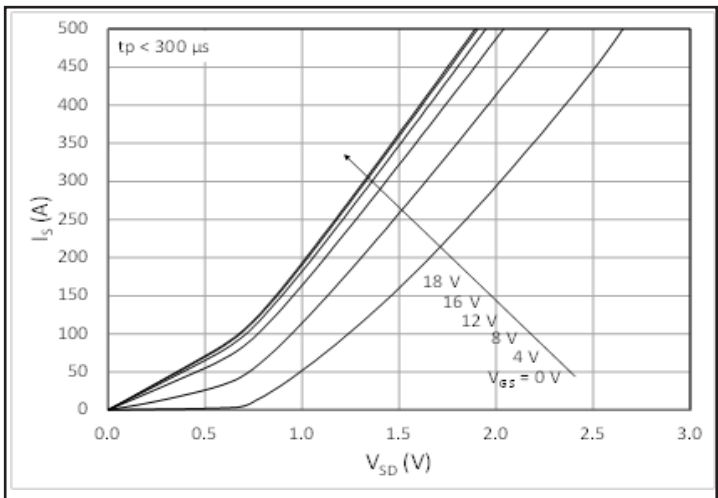


Figure 10. 3<sup>rd</sup> Quadrant Characteristic at 175 °C

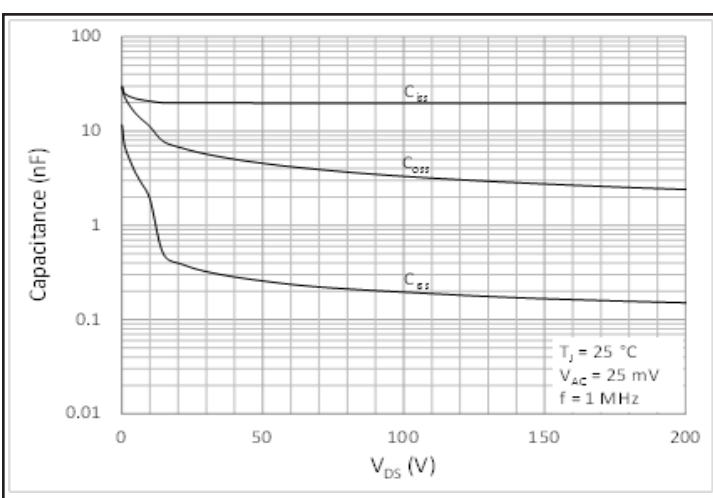


Figure 11. Typical Capacitances vs. Drain-Source Voltage (0 - 200 V)

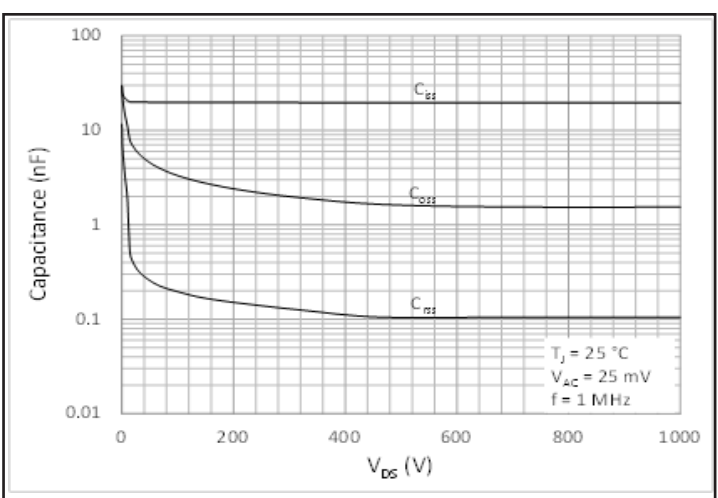


Figure 12. Typical Capacitances vs. Drain-Source Voltage (0 - 1 kV)

## Typical Performance

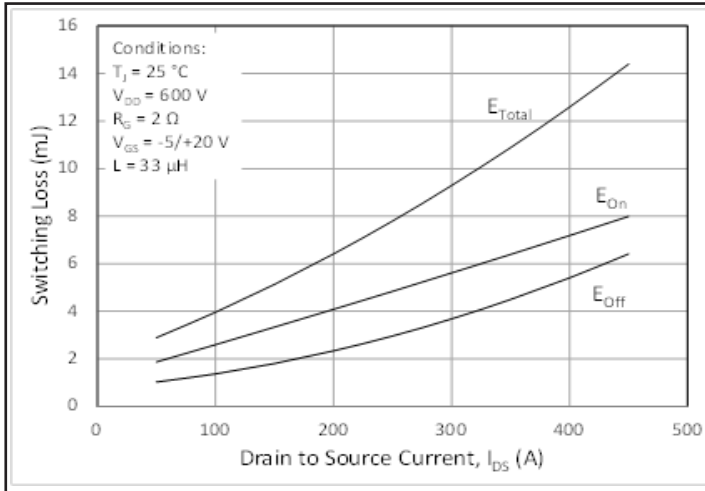


Figure 13. Inductive Switching Energy vs. Drain Current For  $V_{DD} = 600\text{V}$ ,  $R_G = 2\ \Omega$

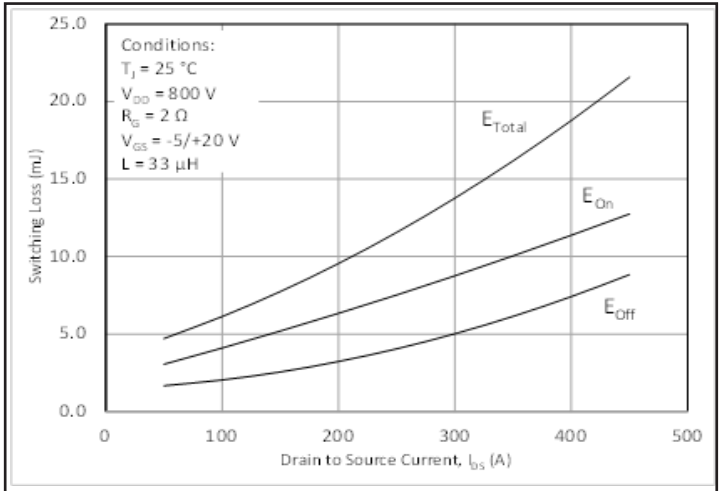


Figure 14. Inductive Switching Energy vs. Drain Current For  $V_{DD} = 800\text{V}$ ,  $R_G = 2\ \Omega$

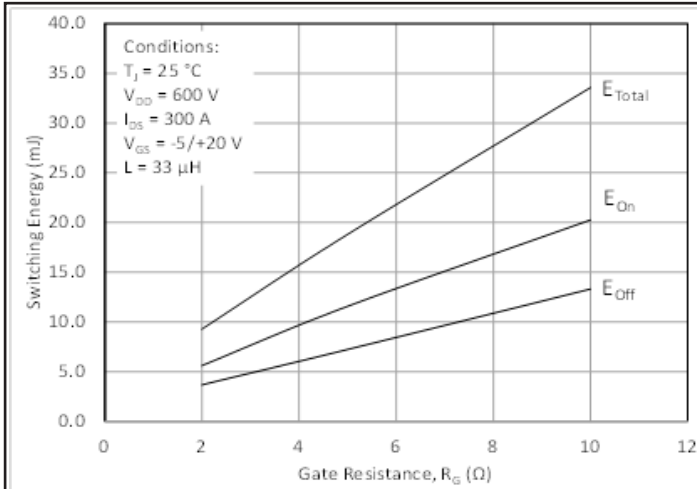


Figure 15. Inductive Switching Energy vs. Gate Resistance,  $I_{DS} = 300\text{A}$

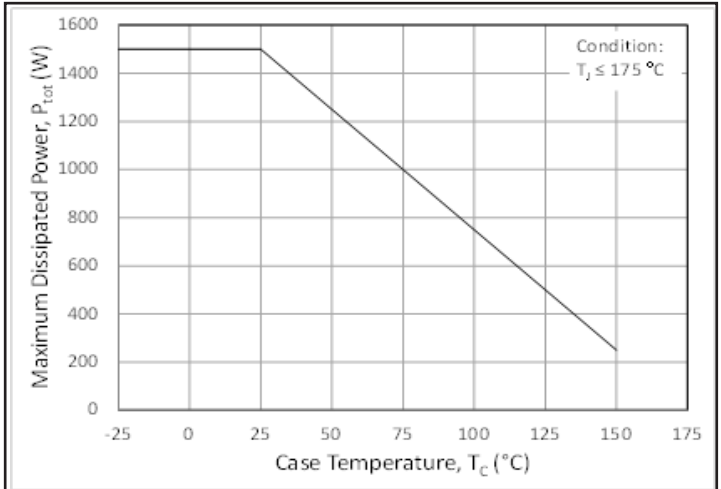


Figure 16. Maximum Power Dissipation (MOSFET) Derating Per Switch Position vs Case Temperature

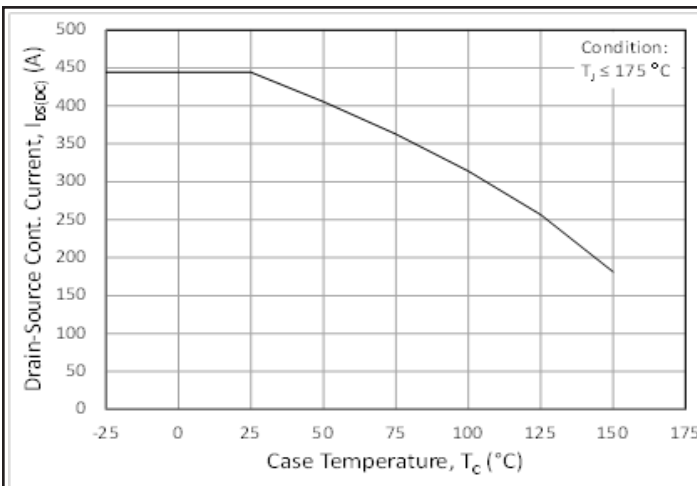


Figure 17. Continuous Drain Current Derating vs Case Temperature

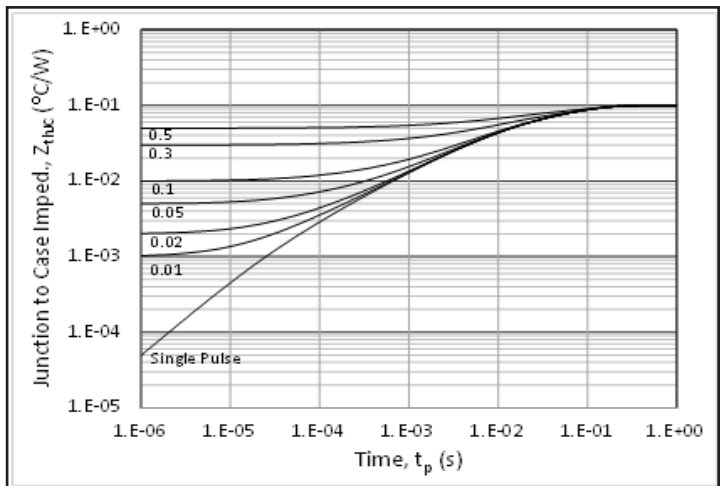


Figure 18. MOSFET Junction to Case Thermal Impedance

## Typical Performance

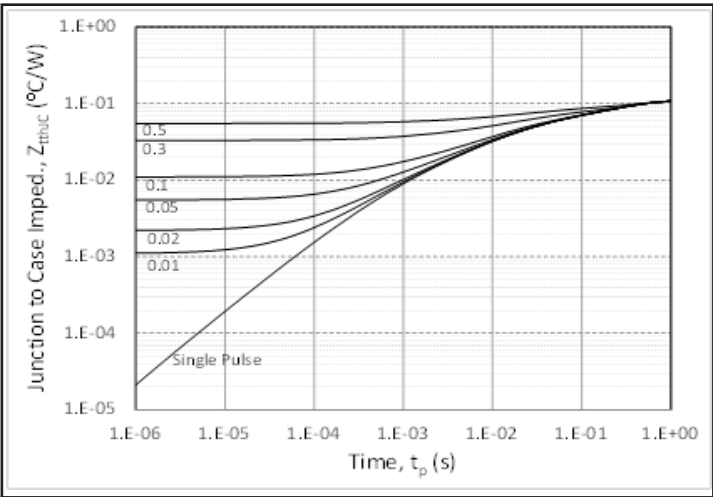
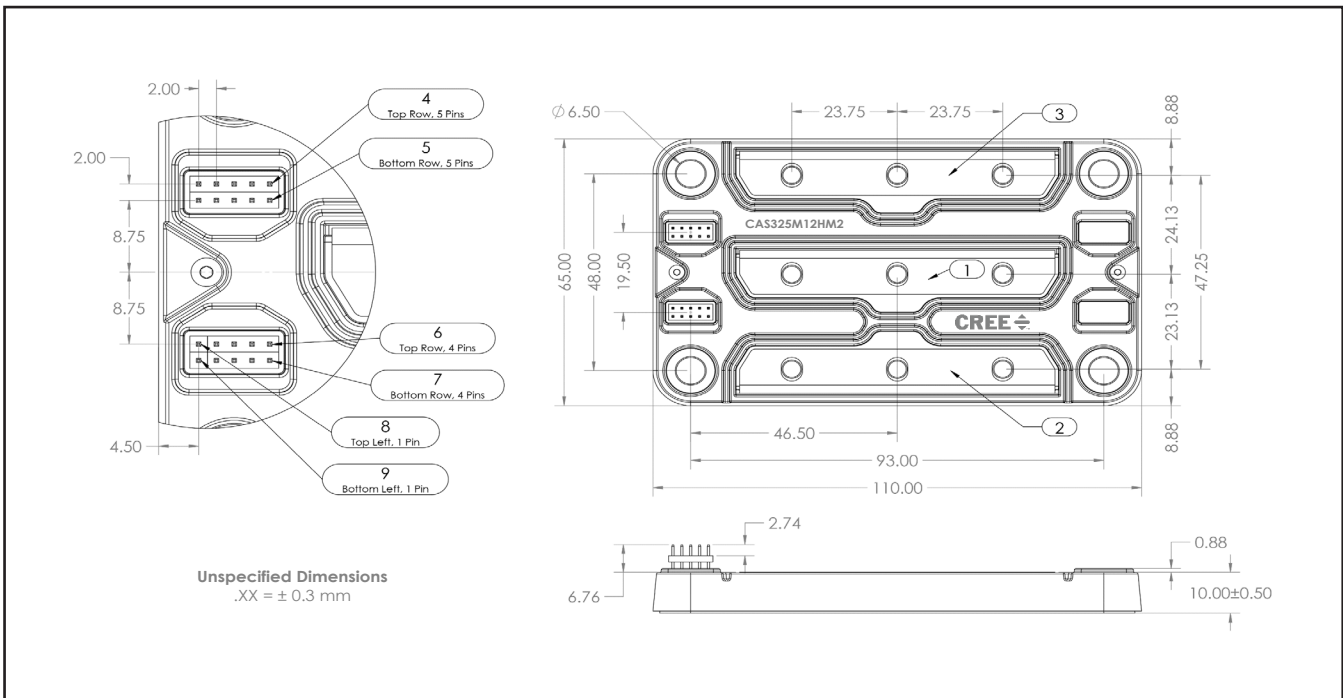


Figure 19. Diode Junction to Case Thermal Impedance

## Package Dimensions (mm)





## Important Notes

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- The SiC MOSFET module switches at speeds beyond what is customarily associated with IGBT-based modules. Therefore, special precautions are required to realize the best performance. The interconnection between the gate driver and module housing needs to be as short as possible. This will afford the best switching time and avoid the potential for device oscillation. Also, great care is required to insure minimum inductance between the module and DC link capacitors to avoid excessive VDS overshoot.
- The module utilizes the ESQT-105-02-G-D-XXX family of elevated socket connectors from Samtec, available in varying height according to the customer's preference
- Companion Parts: CGD15HB62LP + High Performance Three Phase Evaluation Unit
- Some values were obtained from the CPM2-1200-0025B and CPW5-1200-Z050B device datasheet.
- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.
- The product described is not eligible for Distributor Stock Rotation or Inventory Price Protection.